

<b>Notice of References Cited</b>	Application/Control No. 10/809,416		Applicant(s)/Patent Under Reexamination SHINAGAWA ET AL.	
	Examiner Jared I. Rutz		Art Unit 2187	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0080985	04-2004	Chang et al.	365/185.33
*	B	US-6,000,006	12-1999	Bruce et al.	711/103
*	C	US-6,145,051	11-2000	Estakhri et al.	711/103
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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